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Nakamura

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(54) **RETAINER RING AND POLISHING MACHINE**

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451/398, 388, 288, 41
See application file for complete search history.

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(57) **ABSTRACT**

To provide a retainer ring by which an object to be polished can be uniformly polished, and deterioration thereof can be suppressed, and it does not take time to recycle, and a polishing machine having the retainer ring. The retainer ring 1 includes: a first annular portion 11 for surrounding an outer circumferential portion of the object to be polished and made of resin; and a second annular portion 12 provided on the first annular portion 11 and having a mechanical strength higher than that of the first annular portion 11. In rim portions of the first annular portion 11 and the second annular portion 12, a fixing portion 13 for fixing the first annular portion 11 and the second annular portion 12 with mechanical joining is provided. The first annular portion 11 protrudes beyond the fixing portion 13 toward the opposite side of the second annular portion 12.

17 Claims, 10 Drawing Sheets

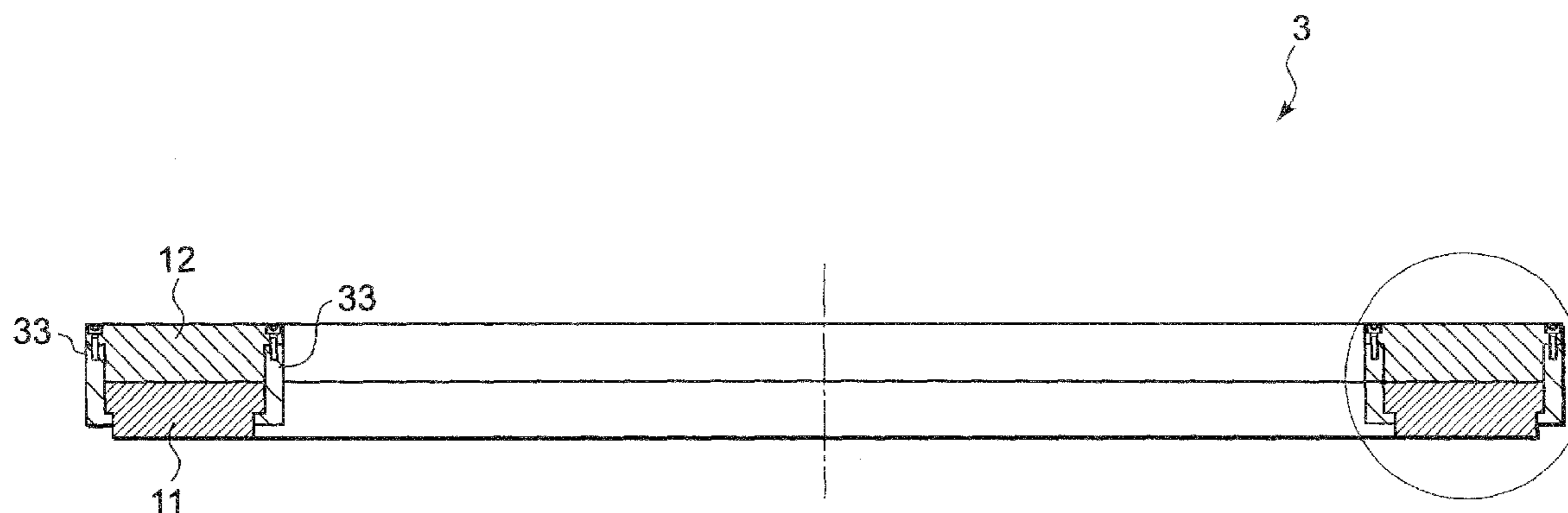


FIG. 1

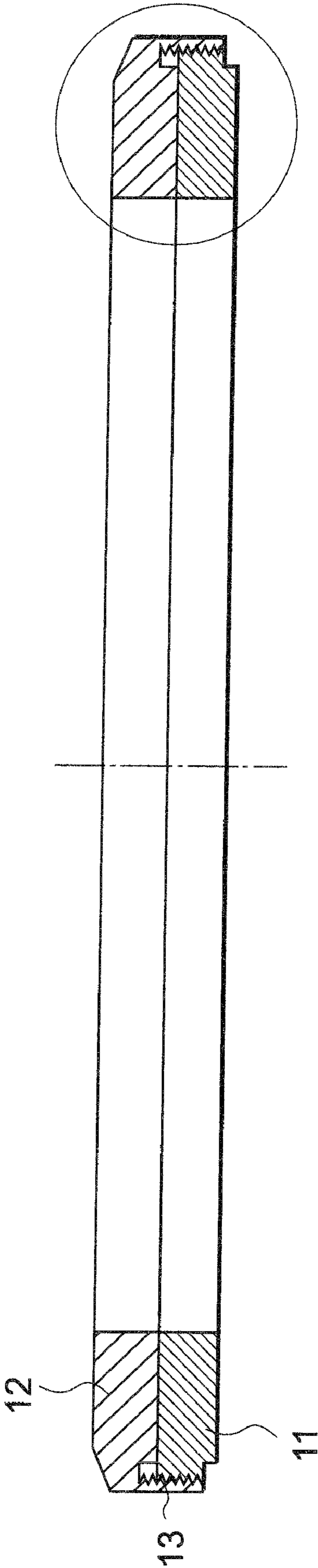


FIG. 2

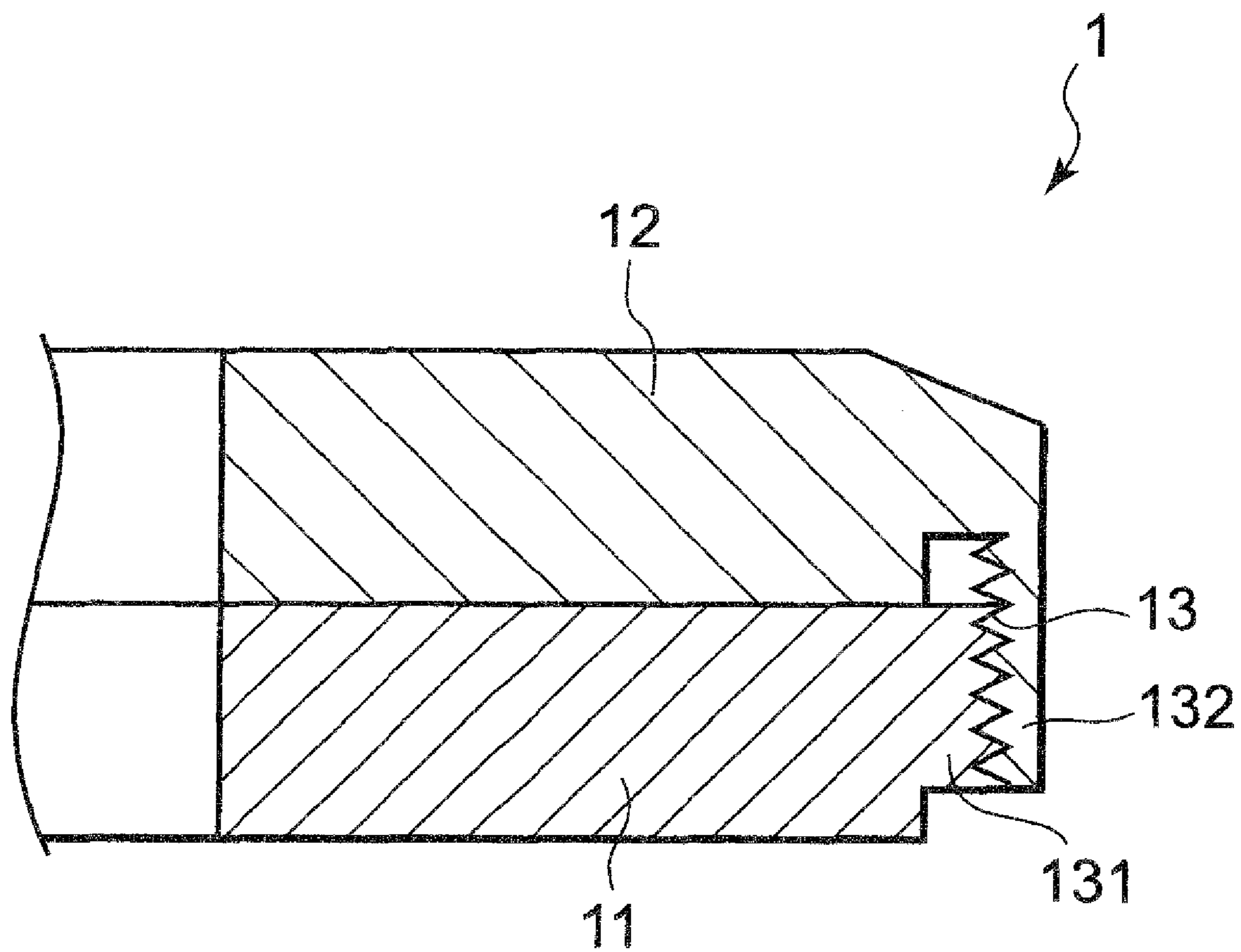


FIG. 3

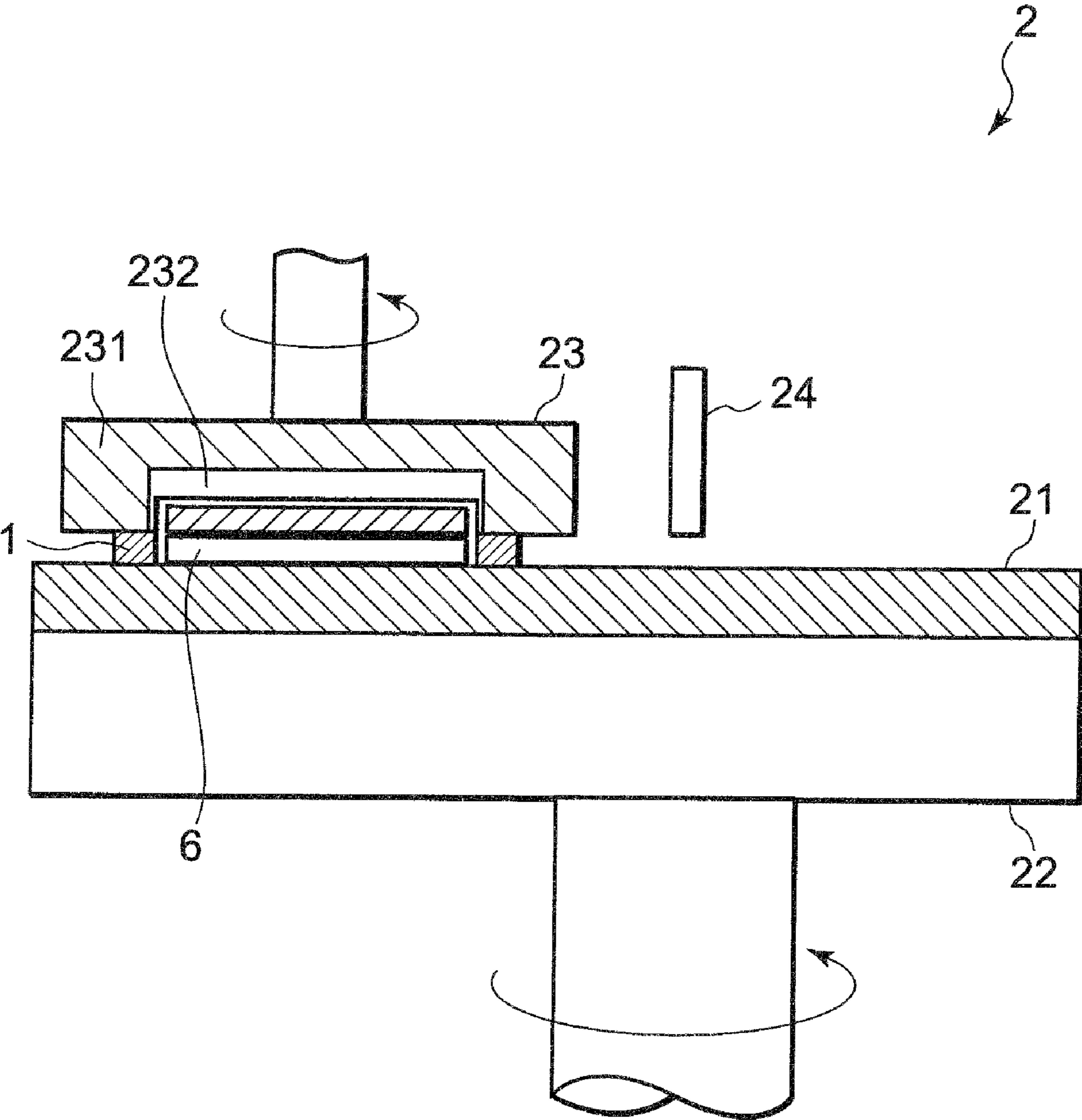


FIG. 4

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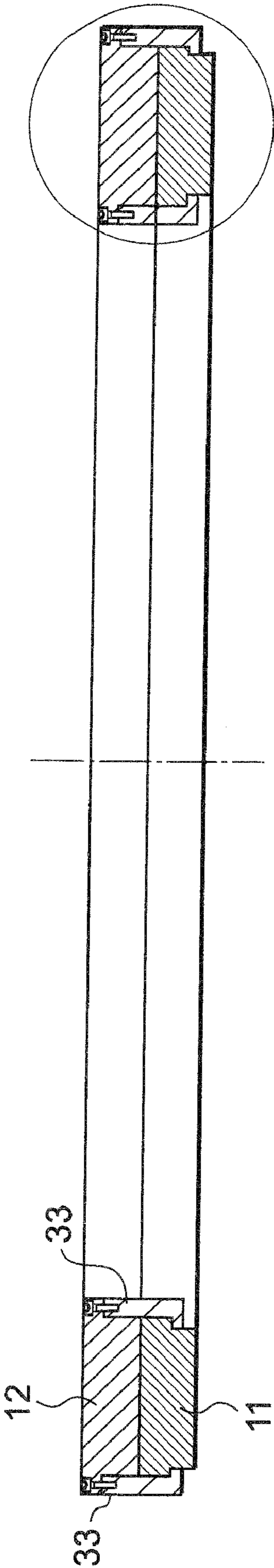


FIG. 5

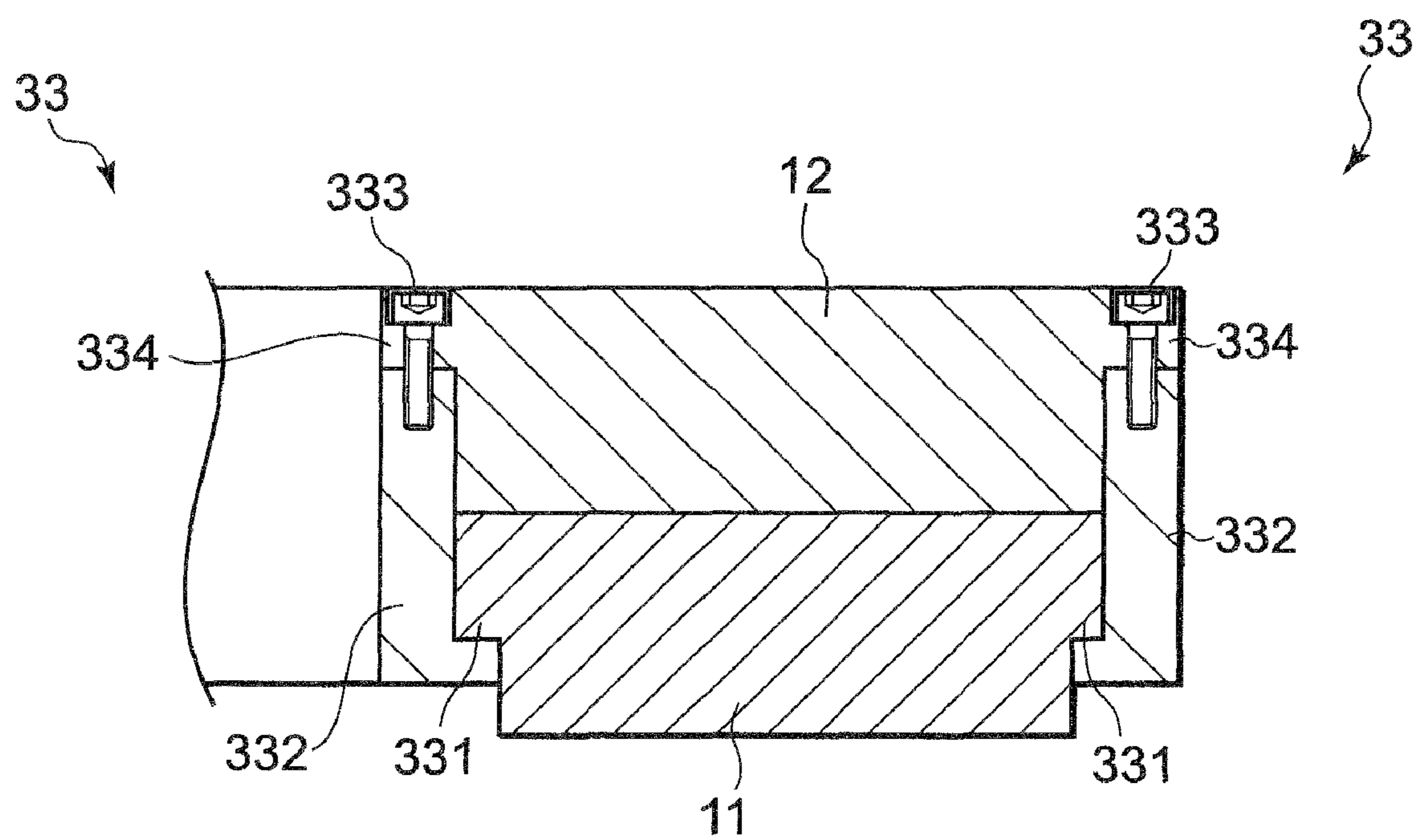


FIG. 6

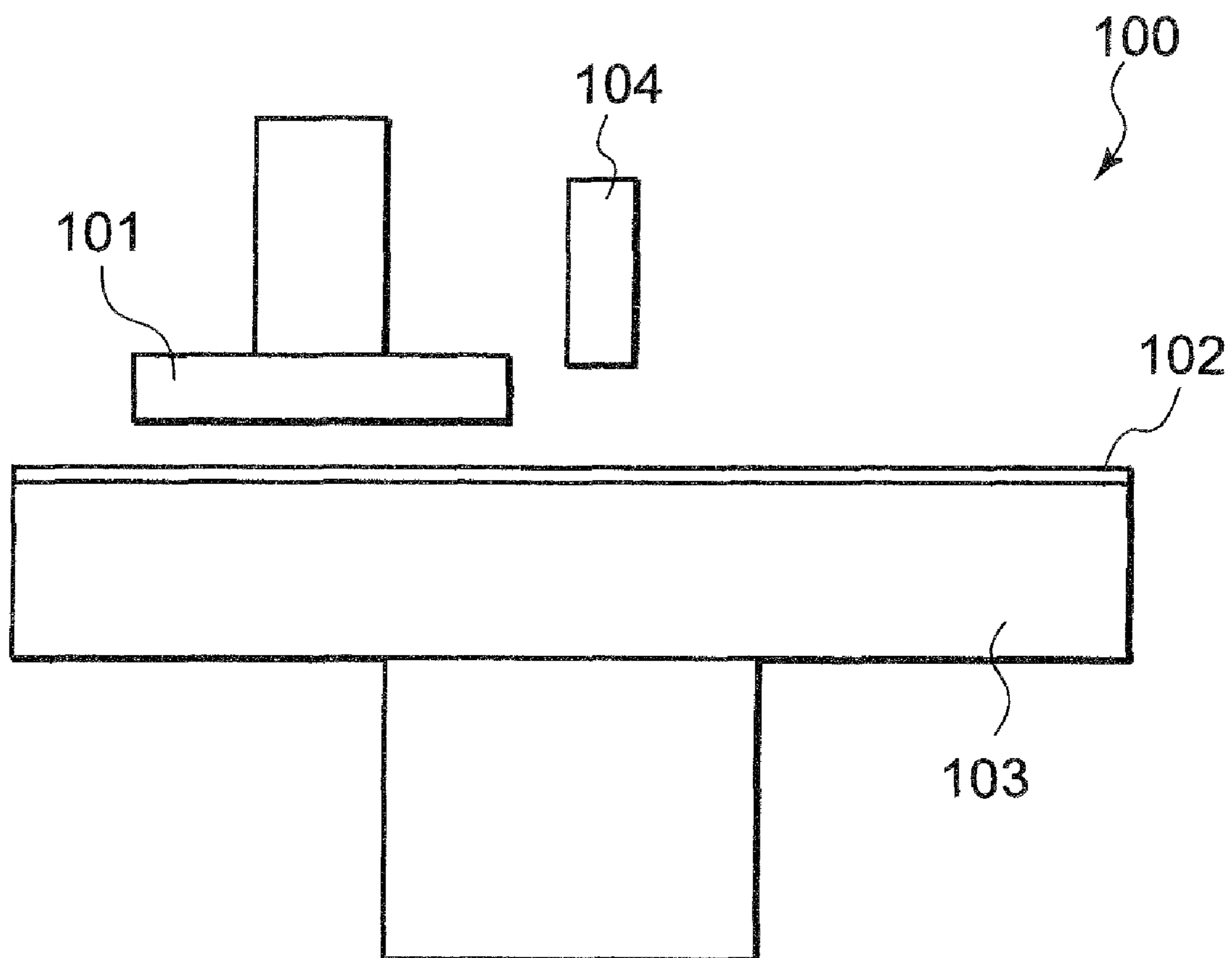


FIG. 7

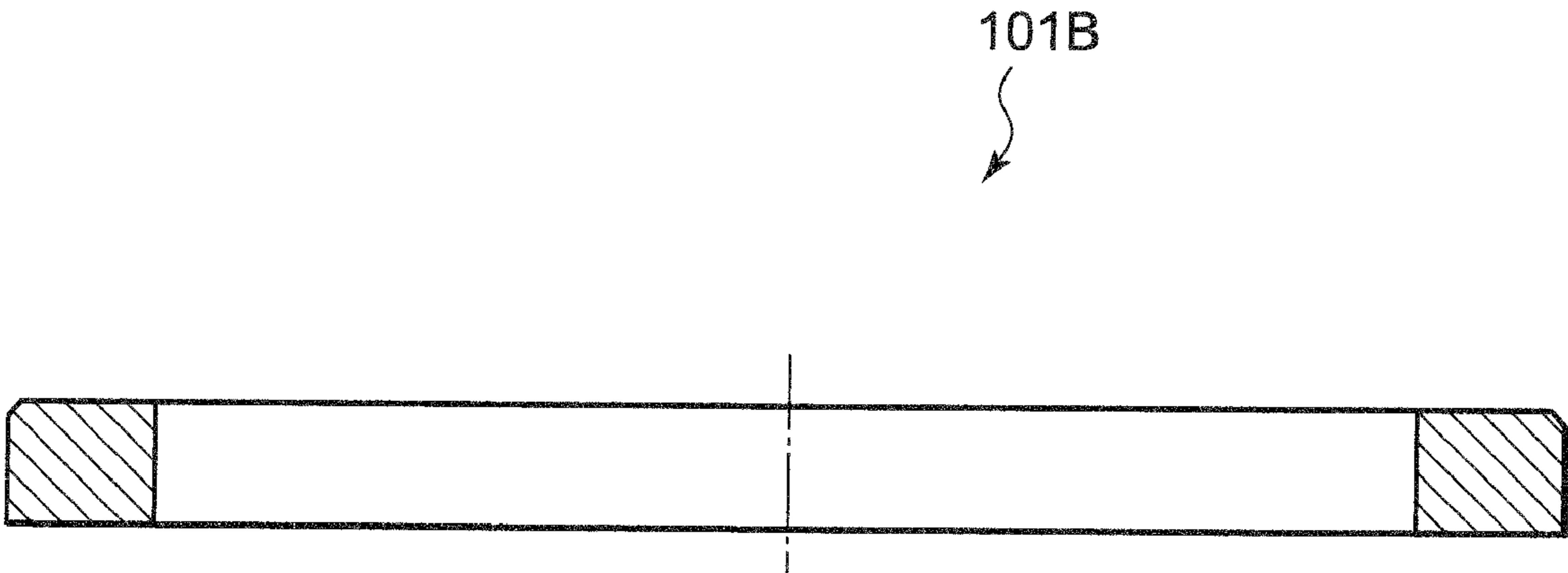


FIG. 8A

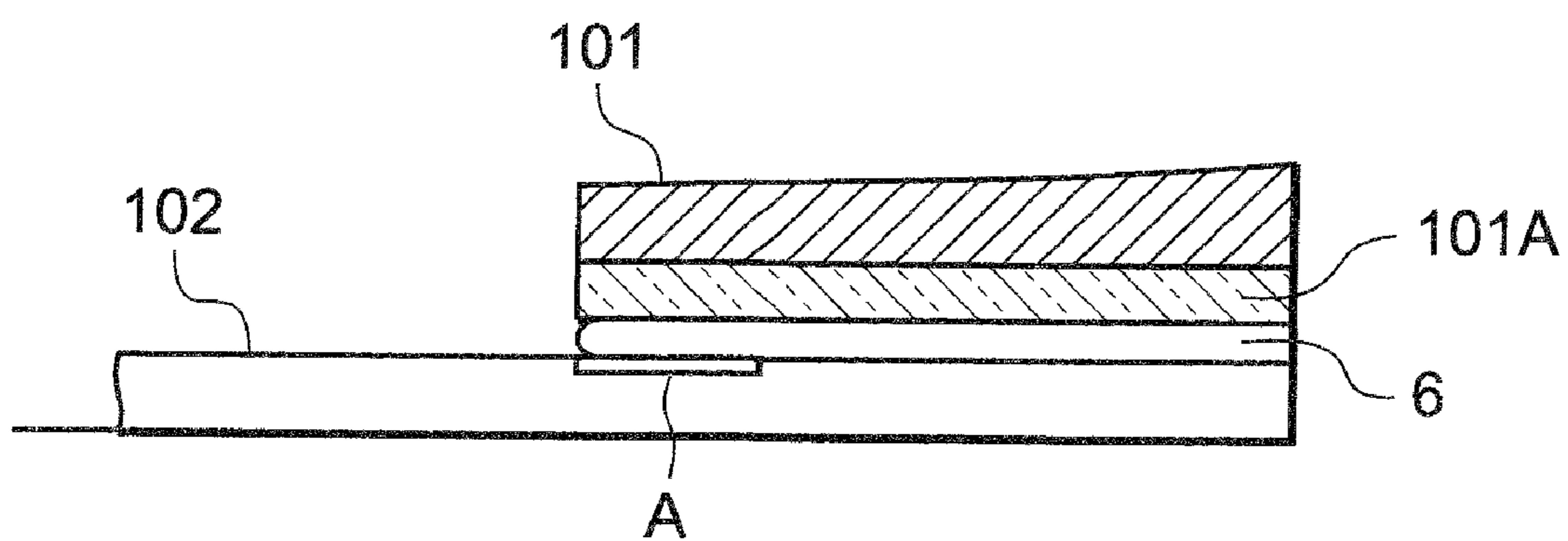


FIG. 8B

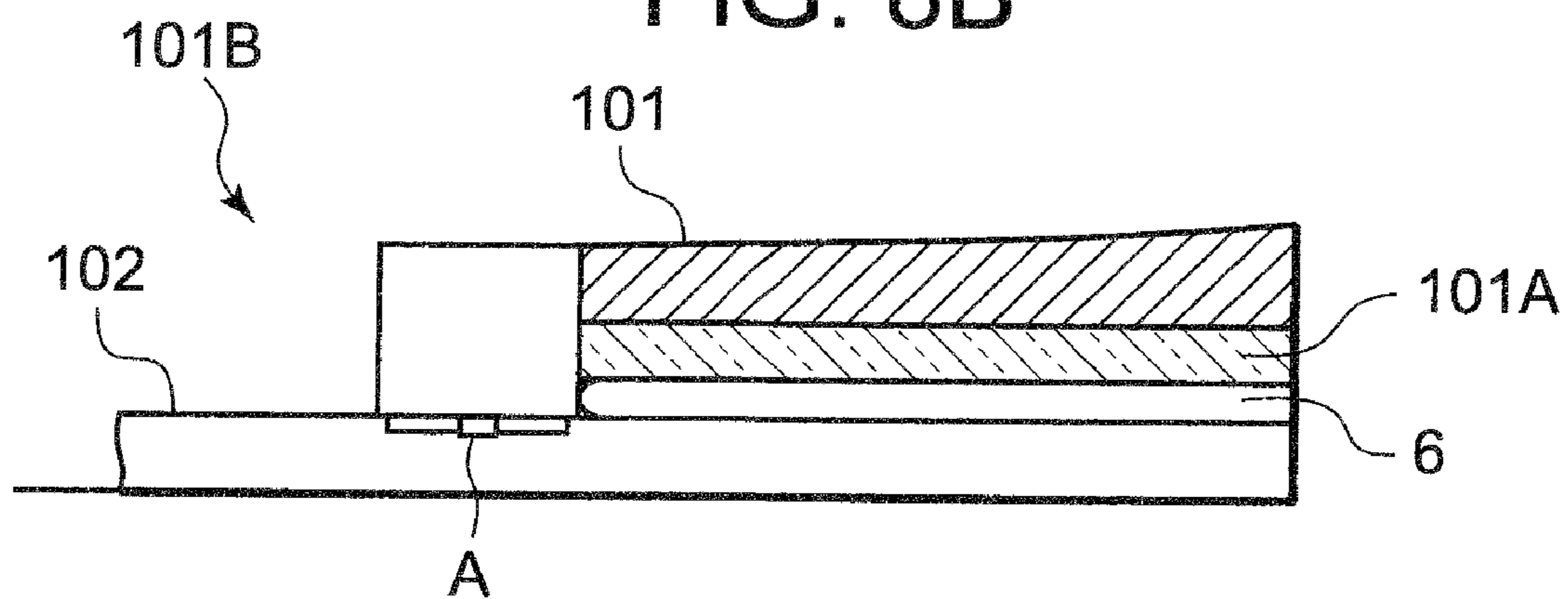


FIG. 9

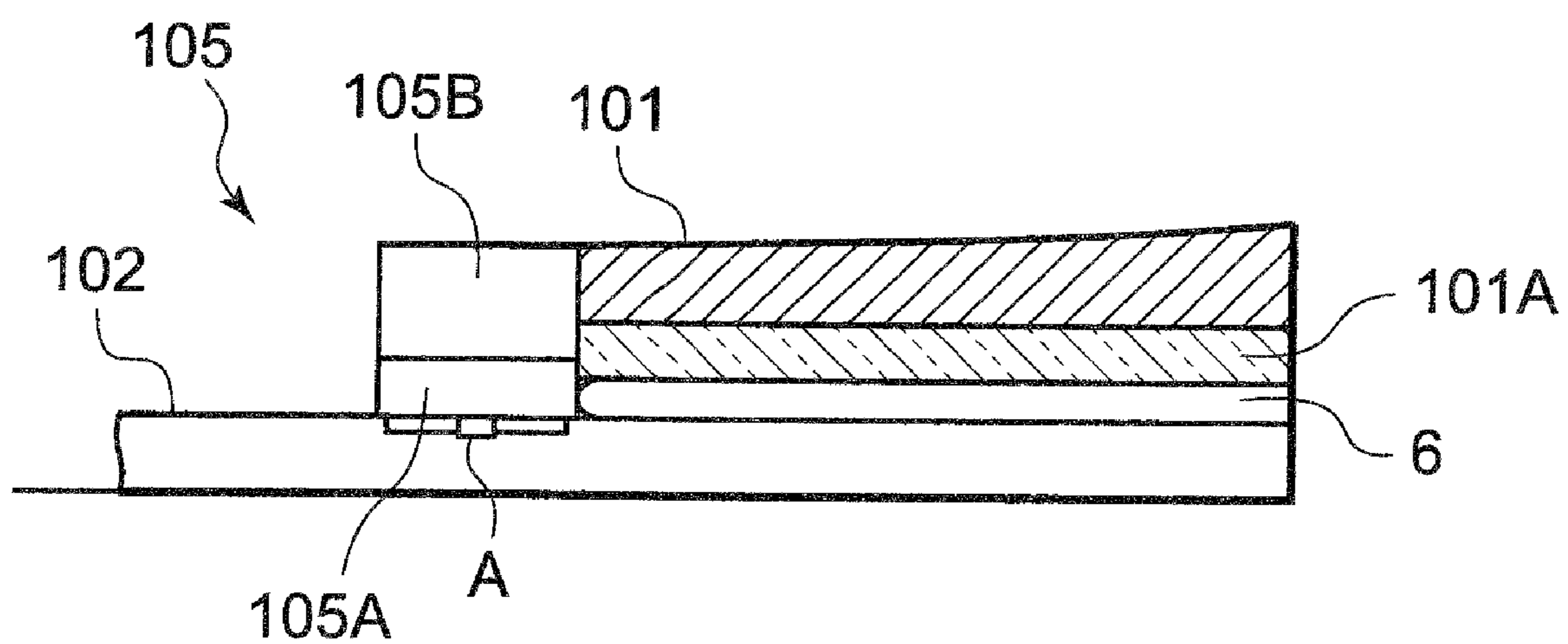
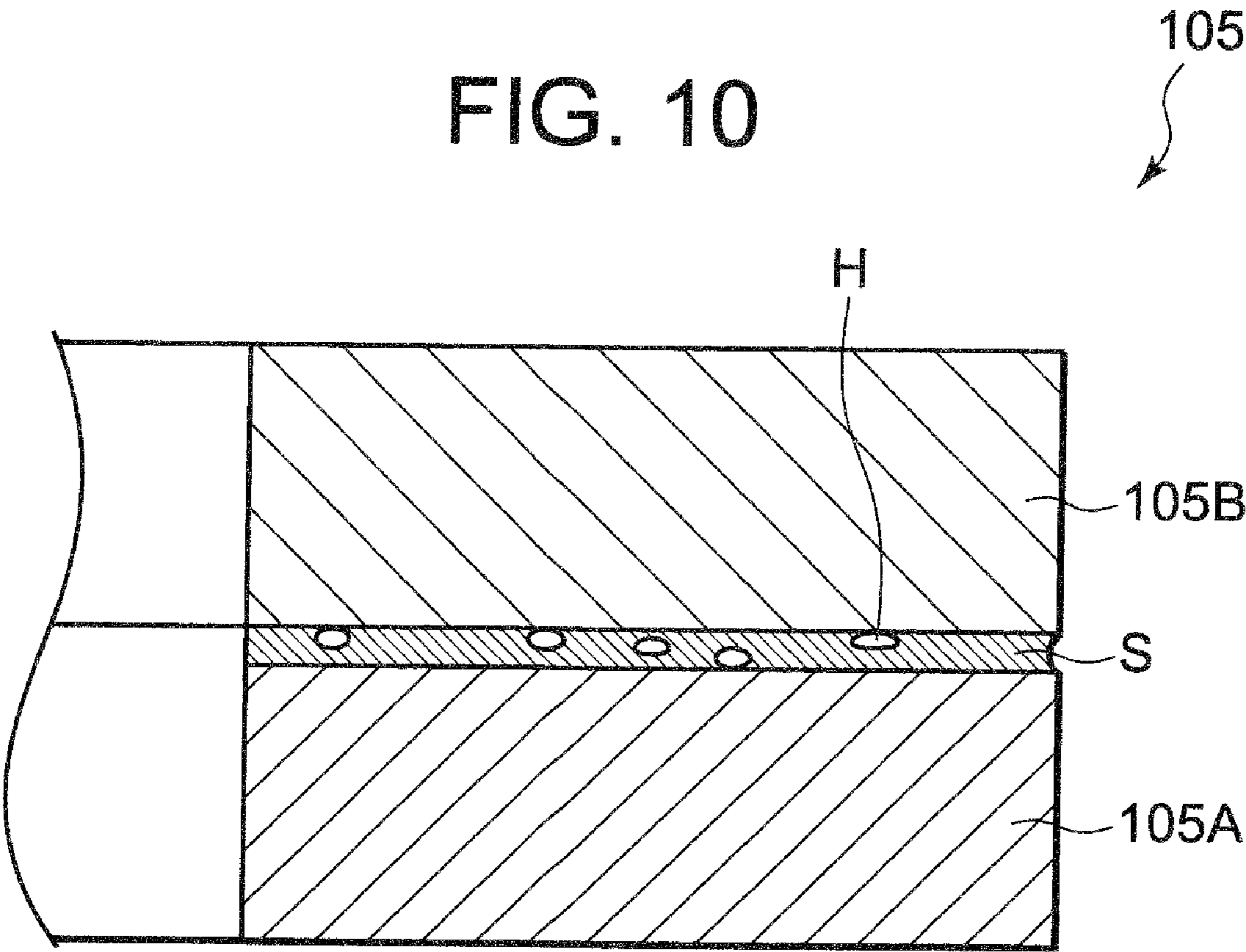


FIG. 10



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RETAINER RING AND POLISHING
MACHINE

BACKGROUND OF THE INVENTION

1. Field of the Invention

The present invention relates to a retainer ring and a polishing machine having the same.

2. Description of the Related Art

Recently, in the process of production of devices on a semiconductor substrate, a chemical mechanical polishing (hereinafter, called "CMP") method is used to flatten unevenness on surfaces generated during the production process, such as unevenness on surfaces of an interlayer insulating film, by polishing.

In CMP, a polishing machine **100** is generally used, as shown in FIG. 6.

The polishing machine **100** includes a gripping portion **101** for gripping an object to be polished (not shown), a polishing table **103** to which a polishing pad **102** is attached and a chemical supply port **104**.

The gripping portion **101** includes a retainer ring **101B** (see FIG. 7).

In polishing, the object to be polished is gripped by the gripping portion **101**, and a polished surface thereof is pressed against the polishing pad **102** and polished. The retainer ring **101B** is used to prevent the object to be polished from flying out of the gripping portion **101** and an outer circumferential portion of the object to be polished from being abnormally polished.

In polishing without use of the retainer ring, a most outer circumferential portion of the object to be polished is subject to the largest contact pressure. At this time, as shown in FIG. 8A, a deformed area A is generated by the effect in the polishing pad **102** across the width of several millimeters from the most outer circumferential portion of the object to be polished **6**, resulting in a lowered pressure acting on the outer circumferential portion of the object to be polished **6**. As the result, a polishing amount of the outer circumferential portion of the object to be polished **6** is reduced.

Then, using the retainer ring **101B**, as shown in FIG. 8B, a surface of the object to be polished **6** in contact with the polishing pad **102** and a surface of the retainer ring **101B** in contact with the polishing pad **102** are made at the same height. Further, a width of the retainer ring **101B** in contact with the polishing pad **102** is set to be equal to or larger than that of the deformed area A. Moreover, to the retainer ring **101B**, a predetermined pressure is applied. This can prevent the deformed area A from extending to the outer circumferential portion of the object to be polished **6**, which can prevent a decrease in the polishing amount by which the outer circumferential portion of the object to be polished **6** is polished (abnormal polishing). In addition, in FIGS. 8A and 8B, the symbol "101A" shows an insert pad provided on a reverse surface of the object to be polished.

The contact of the retainer ring **101B** with the polishing pad **102** polishes the retainer ring **101B**, and impurities spread gradually. Using alloy material such as stainless steel for the retainer ring **101B**, metal components spread over the polishing pad **102**, which may adversely affect characteristics of devices to be formed on the object to be polished **6**. Then, it is thought that rigid plastic is used for the retainer ring **101B**. However, its mechanical strength is lower, compared with stainless steel, and the retainer ring is more deformed as the number of objects to be polished that are processed increases.

Then, as shown in FIG. 9, it was proposed that a retainer ring **105** be composed of a ring-shaped resin portion **105A**

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provided on the polishing pad **102** side and a ring-shaped portion **105B** of stainless steel or the like having a high mechanical strength (see Japanese Patent Laid-Open No. 11-291162).

SUMMARY

However, the technique disclosed in Japanese Patent Laid-Open No. 11-291162 has the following problems.

As shown in FIG. 10, the resin portion **105A** and the ring-shaped portion **105B** made of stainless steel or the like of the retainer ring **105** are bonded to each other with an adhesive S. When the resin portion **105A** and the ring-shaped portion **105B** of stainless steel or the like are fixed with the adhesive S, a bubble H occurs in the inside of the adhesive S in the case of an insufficient amount of the adhesive S or poor deairing. Due to the generated bubble H, a pressure cannot be uniformly applied to the polishing pad **102** by the retainer ring **105**, resulting in imbalanced pressure transfer. Accordingly, the deformed area A of the polishing pad **102** extends not only to an area under the retainer ring **105**, but to a contact portion with the outer circumferential portion of the object to be polished **6**. Thus, the polishing amount of the outer circumferential portion of the object to be polished **6** is made different from that in another portion, and it becomes difficult to uniformly polish the object to be polished **6**.

Further, in polishing, a chemical such as acids or alkalis is supplied by the chemical supply port **104**, and the chemical may corrode the adhesive S, and the retainer ring **105** may deteriorate.

Further, when a used retainer ring **105** is recycled, a method has been used in which only the resin portion **105A** is changed, and the adhesive S is left behind on the side of the ring-shaped portion **105B** of stainless steel or the like having a high mechanical strength. Then, it takes time to remove the adhesive S, and it is difficult to easily recycle the retainer ring **105**.

The present invention provides a retainer ring for holding an outer circumferential portion of an object to be polished, comprising: a first annular portion for surrounding the outer circumferential portion of the object, and a second annular portion provided on the first annular portion, wherein the second annular portion is fixed to the first annular portion by a mechanical joining.

Further, the present invention provides a polishing machine comprising: a polishing pad for polishing an object, and a gripping portion for gripping the object and bringing the object into contact with the polishing pad, wherein the gripping portion has a retainer ring for holding an outer circumferential portion of the object, and the retainer ring includes: a first annular portion for surrounding the outer circumferential portion of the object and being brought into contact with the polishing pad, and a second annular portion provided on the first annular portion, and wherein the second annular portion is fixed to the first annular portion by a mechanical joining.

According to the present invention, the retainer ring has the fixing portion for fixing the first annular portion and the second annular portion provided in the rim portions of the first annular portion and the second annular portion. Then, the first annular portion protrudes beyond the fixing portion toward the opposite side of the second annular portion. Accordingly, in polishing, the fixing portion is not made in contact with the polishing pad, and only the first annular portion can be brought into contact with the polishing pad. Accordingly, a pressure is uniformly applied to the polishing pad by the retainer ring, and the deformed area of the polishing pad can

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be prevented from extending to the contact portion of the polishing pad with the outer circumferential portion of the object to be polished. Thus, the polishing amount of the outer circumferential portion of the object to be polished can be prevented from differing from that of another portion, and thereby the object to be polished can be uniformly polished.

Further, the fixing portion is used to fix the first annular portion and the second annular portion with mechanical joining, and the adhesive does not corrode as conventionally, which can suppress deterioration of the retainer ring. Further, in recycling the retainer ring, it becomes unnecessary to remove the adhesive, and the retainer ring can be easily recycled.

Also, the present invention can provide the retainer ring by which the object to be polished can be uniformly polished, deterioration can be suppressed, and easy recycling is achieved, and the polishing machine including this retainer ring.

BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a cross-section view of a retainer ring according to a first embodiment of the present invention;

FIG. 2 is an enlarged cross-section view of a main portion of the retainer ring;

FIG. 3 is a schematic diagram illustrating a polishing machine;

FIG. 4 is a cross-section view of a retainer ring according to a second embodiment of the present invention;

FIG. 5 is an enlarged cross-section view of a main portion of the retainer ring;

FIG. 6 is a schematic diagram illustrating a conventional polishing machine;

FIG. 7 is a cross-section view illustrating a conventional retainer ring;

FIG. 8A shows a state that an object to be polished is polished in the conventional polishing machine;

FIG. 8B shows a state that an object to be polished is polished in the conventional polishing machine using the retainer ring;

FIG. 9 shows a state that an object to be polished is polished in the conventional polishing machine using the retainer ring; and

FIG. 10 is a cross-section view of a main portion of the conventional retainer ring.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENTS

Now, embodiments of the present invention will be described with reference to the accompanying drawings.

First Embodiment

First, referring to FIGS. 1 to 3, a retainer ring of the present embodiment will be schematically described. In addition, in the following description, a like portion as the portion already described will be shown by a like symbol and the description will be omitted.

A retainer ring 1 of the present embodiment holds an outer circumferential portion of an object to be polished 6, and is brought into contact with a polishing pad 21 along with the object to be polished 6. The object to be polished 6 is a circular substrate, for example, a semiconductor wafer. In addition, in a part of a peripheral portion of the circular substrate, a notch for alignment (the portion in which a

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V-shaped groove is formed in the part of the peripheral portion of the substrate) may be formed.

The retainer ring 1 includes: a first annular portion 11 for surrounding the outer circumferential portion of the object to be polished 6; and a second annular portion 12 provided on the first annular portion 11 and having a mechanical strength higher than that of the first annular portion 11.

In rim portions of the first annular portion 11 and the second annular portion 12, a fixing portion 13 for fixing the first annular portion 11 and the second annular portion 12 with mechanical joining is provided.

The first annular portion 11 protrudes beyond the fixing portion 13 toward the opposite side of the second annular portion 12. That is, a surface of the first annular portion 11 on the polishing pad 21 side protrudes beyond a surface of the fixing portion 13 on the polishing pad 21 side toward the polishing pad 21 side.

Next, the retainer ring 1 will be described in detail.

As shown in FIGS. 1 and 2, the retainer ring 1 includes a first annular portion 11 made of resin, a second annular portion 12 and a fixing portion 13. In addition, FIG. 1 is a cross-section view of the retainer ring 1, and FIG. 2 is an enlarged view of a part surrounded by the circle in FIG. 1.

The first annular portion 11 is formed in an annular shape. In polishing, the object to be polished 6 is fitted into an inner circumferential side of the first annular portion 11 (see FIG. 3).

The first annular portion 11, in polishing the object to be polished 6, for example, a substrate is brought into contact with the polishing pad 21 (see FIG. 3). For the purpose, the first annular portion 11 is preferably formed of a chemically stable member in polishing. Also, the member is preferably a member that will not adversely affect characteristics of devices to be formed on the object to be polished 6 even if the contact causes a part of components of the member constituting the first annular portion 11 to diffuse over the polishing pad. Such first annular portion 11 is, for example, made of resin, and more particularly contains, for example, polyethylene terephthalate resin.

The second annular portion 12 is disposed on the first annular portion 11, and formed in an annular shape. The second annular portion 12 is composed of a member having a mechanical strength higher than that of the first annular portion 11. For example, the second annular portion 12 is made of metal such as stainless steel.

The fixing portion 13 is used to fix the first annular portion 11 and the second annular portion 12 with mechanical joining. The fixing portion 13 includes a male thread portion 131 provided in an outer circumferential portion of the first annular portion 11 and a female thread portion 132 provided in an outer circumferential portion of the second annular portion 12.

The male thread portion 131 is integrally formed with the first annular portion 11, and made of the same resin as the first annular portion 11. On an outer circumferential surface of the male thread portion 131, a screw thread is provided. An upper surface of the male thread portion 131 is situated at the same height as a surface of the first annular portion 11 on the second annular portion 12 side.

Further, a lower surface of the male thread portion 131 (the surface situated on the polishing pad 21 side when being mounted on a polishing machine 2) is situated closer on the second annular portion 12 side than a surface of the first annular portion 11 on the polishing pad 21 side. That is, the first annular portion 11 protrudes beyond the male thread portion 131 toward the opposite side of the second annular portion 12.

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The female thread portion **132** is integrally formed with the second annular portion **12**, and made of the same material as the second annular portion **12**. The female thread portion **132** has a threaded hole formed therein, and on an inner circumferential surface of the threaded hole, a screw thread is provided. An upper surface of the threaded hole is situated higher than a surface of the second annular portion **12** on the first annular portion **11** side. Then, between the upper surface of the male thread portion **131** and the upper surface of the threaded hole of the female thread portion **132**, a gap is formed. Such gap formation can prevent the male thread portion **131** from being damaged when the male thread portion **131** is too much pushed into the threaded hole of the female thread portion **132**.

Further, a lower surface of the female thread portion **132** (the surface situated on the polishing pad **21** side when being mounted on the polishing machine **2**) is situated closer on the second annular portion **12** side than a surface of the first annular portion **11** on the polishing pad **21** side. That is, the first annular portion **11** protrudes beyond the female thread portion **132** toward the opposite side of the second annular portion **12**.

The female thread portion **132** and the male thread portion **131** of the fixing portion **13** as configured above are screwed together, and thereby the first annular portion **11** and the second annular portion **12** are fixed and the retainer ring **1** is assembled.

The retainer ring **1** as configured in a way described above, as shown in FIG. **3**, is incorporated in a polishing machine **2**.

The polishing machine **2** includes a polishing table **22**, a gripping portion **23** for gripping the object to be polished **6** and a nozzle **24** for supplying a chemical. The polishing machine **2** is, for example, a CMP apparatus, and polishes an insulating film or a metal film formed on a surface of a semiconductor wafer.

The polishing table **22** is configured to be rotatable, and on a surface of the polishing table **22**, a polishing pad **21** is provided. From the nozzle **24**, a chemical, for example, slurry is supplied onto a surface of the polishing pad **21**. The CMP apparatus polishes the object to be polished **6** using a mechanical effect and a chemical effect due to components in the slurry.

The gripping portion **23** grips the object to be polished **6**, and in polishing, brings a polished surface of the object to be polished **6** into contact with the polishing pad **21** and presses it. The gripping portion **23** includes a polishing head **231** and a retainer ring **1** to be disposed under the polishing head **231**. The polishing head **231** rotates and swings the object to be polished **6** held by the retainer ring **1**. Between the polishing head **231** and the object to be polished **6**, an insert pad **232** is placed.

The polishing machine **2** is configured so that, to the retainer ring **1**, a load is applied by air cushion (not shown), and a pressure applied to the retainer ring **1** is adjustable, except for a press pressure of the object to be polished **6** applied to the polishing pad **21**.

In such polishing machine **2**, the retainer ring **1** holds the object to be polished **6**, and the retainer ring **1** is mounted on the polishing head **231**. The object to be polished **6** held by the retainer ring **1** is pressed against the polishing pad **21**, and the polishing head **231** and the polishing table **22** are rotated, and the chemical is supplied from the nozzle **24**. Accordingly, the object to be polished **6** is polished. In addition, in polishing, the first annular portion **11** of the retainer ring **1** is brought into a state of contact with the polishing pad **21**, but the fixing portion **13** does not contact the polishing pad **21**.

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Next, operation and advantages of the present embodiment will be described.

The retainer ring **1** has the fixing portion **13** for fixing the first annular portion **11** and the second annular portion **12** provided therein. Then, the first annular portion **11** protrudes beyond the fixing portion **13** toward the opposite side of the second annular portion **12**. That is, the surface of the first annular portion **11** on the polishing pad **21** side protrudes closer on the polishing pad **21** side than the surface of the fixing portion **13** on the polishing pad **21** side. Then, only the surface of the first annular portion **11** on the polishing pad **21** side can be made in contact with the polishing pad **21**. Accordingly, a pressure is uniformly applied to the polishing pad **21** by the retainer ring **1**, and the deformed area of the polishing pad **21** can be prevented from extending to the contact portion of the polishing pad **21** with the outer circumferential portion of the object to be polished **6**. Thus, the object to be polished **6** can be uniformly polished.

Also, in the present embodiment, as described above, the fixing portion **13** does not contact the polishing pad **21** and only the first annular portion **11** contacts the polishing pad **21**, and thereby a pressure can be uniformly applied to the polishing pad **21** by the retainer ring **1**. Accordingly, the deformed area of the polishing pad **21** can be prevented from extending to the contact portion of the polishing pad **21** with the outer circumferential portion of the object to be polished **6**.

Further, the fixing portion **13** is used to fix the first annular portion **11** and the second annular portion **12** with mechanical joining, and the adhesive does not corrode as conventionally, which can suppress deterioration of the retainer ring **1**. Further, in recycling the retainer ring **1**, it becomes unnecessary to remove the adhesive, and the retainer ring **1** can be easily recycled.

Moreover, in the present embodiment, the fixing portion **13** includes the male thread portion **131** provided in the outer circumferential portion of the first annular portion **11** and the female thread portion **132** provided in the outer circumferential portion of the second annular portion **12**. Only screwing the male thread portion **131** and the female thread portion **132** together can fix the first annular portion **11** and the second annular portion **12**, so that the retainer ring **1** can be easily assembled.

Further, the male thread portion **131** is integrally formed with the first annular portion **11**, and the female thread portion **132** is integrally formed with the second annular portion **12**, which can prevent an increase in the number of components for constituting the retainer ring **1**.

Also, screwing the male thread portion **131** and the female thread portion **132** together can firmly fix the first annular portion **11** and the second annular portion **12**.

Second Embodiment

Referring to FIGS. **4** and **5**, a second embodiment will be described. FIG. **4** is a cross-section view of a retainer ring **3** of the present embodiment, and FIG. **5** is an enlarged view of a part surrounded by the circle in FIG. **4**.

The present embodiment differs from the embodiment described above in a structure of the fixing portion. The other points are similar to the embodiment described above.

A fixing portion **33** of the retainer ring **3** of the present embodiment includes a projecting portion **331** protruding from a rim portion of a first annular portion **11**, a support portion **332** with which the projecting portion **331** engages,

and a projecting portion 334 and a coupling member 333 for connecting the support portion 332 to a second annular portion 12.

In addition, in the present embodiment, the fixing portion 33 is provided on an inner circumferential side and an outer circumferential side of the first annular portion 11 and the second annular portion 12, respectively.

The projecting portion 331 protrudes outward from an outer circumferential portion and an inner circumferential portion of the first annular portion 11, respectively. These projecting portions 331 are integrally formed with the first annular portion 11, and made of the same material as the first annular portion 11.

The support portion 332 is formed in an annular shape. The support portion 332 has a cross section having an approximate L-shape, and an end portion of the L-shape receives and supports the projecting portion 331. This support portion 332 can be made, for example, of the same material as the second annular portion 12. The support portion 332 is placed on the inner circumferential side and the outer circumferential side of the second annular portion 12, respectively. Further, a surface of the support portion 332 on the polishing pad 21 side draws away from a surface of the first annular portion 11 on the polishing pad 21 side. That is to say, the first annular portion 11 protrudes beyond the support portion 332 toward the opposite side of the second annular portion 12.

A object to be polished 6 is fitted into a step portion formed by a surface of such support portion 332 on the polishing pad 21 side and a portion of an inner surface of the first annular portion 11 protruding beyond the support portion 332 toward the polishing pad 21 side, and the object to be polished 6 is held by the retainer ring 3.

The projecting portion 334 protrudes outward from an upper end of an outer circumferential portion and an upper end of an inner circumferential portion of the second annular portion 12, respectively. The support portion 332 is placed under the projecting portion 334, and the projecting portion 334 and the support portion 332 are fixed with a screw that is the coupling member 333, and thereby the support portion 332 is connected to the second annular portion 12. Accordingly, the second annular portion 12 is fixed to the first annular portion 11 by the mechanical joining.

The present embodiment as described above can provide similar advantages to the first embodiment, and further provide the following advantages.

In the present embodiment, the fixing portion 33 is provided on the inner circumferential side and the outer circumferential side of the first annular portion 11 and the second annular portion 12, respectively. Accordingly, the fixing portion 33 can firmly fix the first annular portion 11 and the second annular portion 12.

Further, in the present embodiment, the object to be polished 6 does not necessarily have to be circular, and can have any shape such as a square shape.

In addition, the present invention is not limited to the embodiments described above, and changes and improvements in the range in which the object of the present invention can be achieved fall into the scope of the invention.

For example, in each embodiment described above, the second annular portion has been made of metal, but is not limited to this, and it may be any one having a mechanical strength higher than that of the first annular portion. For example, the second annular portion may be made of ceramics.

Also, in the first embodiment, the fixing portion 13 has included the male thread portion 131 provided in the first annular portion 11 and the female thread portion 132 pro-

vided in the second annular portion 12, but is not limited to this, the female thread portion may be provided in the first annular portion and the male thread portion may be provided in the second annular portion.

Further, the joining way of the fixing portion is not limited to the way shown in each embodiment described above, but it may be any mechanical joining. For example, by engagement, the first annular portion and the second annular portion may be connected to each other.

What is claimed is:

1. A retainer ring for holding an outer circumferential portion of an object to be polished, comprising:

a first annular portion for surrounding said outer circumferential portion of said object, said first annular portion having a first outer rim portion, a first inner rim portion, and an upper surface extending radially from the first inner rim portion to the first outer rim portion, and

a second annular portion provided on said first upper surface of said first annular portion, said second annular portion having a second outer rim portion, a second inner rim portion, and a lower surface extending radially from the second inner rim portion to the second outer rim portion,

wherein said second annular portion is fixed to said first annular portion by a mechanical joining,

wherein an entirety of said upper surface of said first annular portion is in contact with said lower surface of said second annular portion,

and wherein said mechanical joining includes a first thread provided in a surface of said first outer rim portion of said first annular portion, and a second projecting portion protruding from said second outer rim portion of said second annular portion and provided with a second thread configured to mate with said first thread.

2. A retainer ring for holding an outer circumferential portion of an object to be polished, comprising:

a first annular portion for surrounding said outer circumferential portion of said object, said first annular portion having a first outer rim portion, a first inner rim portion, and an upper surface extending radially from the first inner rim portion to the first outer rim portion, and

a second annular portion provided on said first upper surface of said first annular portion, said second annular portion having a second outer rim portion, a second inner rim portion, and a lower surface extending radially from the second inner rim portion to the second outer rim portion;

a projecting portion protruding from one of said first outer rim portion and said first inner rim portion; and

a support portion, having a first portion configured to engage with said projecting portion to support said first annular portion, and having a second portion fixed to said second annular portion with a mechanical fastener to fix said second annular portion to said first annular portion, and

wherein an entirety of said upper surface of said first annular portion is in contact with said lower surface of said second annular portion.

3. The retainer ring according to claim 1, wherein said second annular portion has a mechanical strength higher than that of said first annular portion.

4. The retainer ring according to claim 1, wherein said first annular portion is made of a resin.

5. The retainer ring according to claim 1, wherein said second annular portion is made of a metal.

6. The retainer ring according to claim 1, wherein said second annular portion is made of a ceramic material.

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7. A polishing machine, comprising:
 a polishing pad for polishing an object; and
 a gripping portion for gripping said object and bringing
 said object into contact with said polishing pad,
 wherein said gripping portion has a retainer ring for hold- 5
 ing an outer circumferential portion of said object,
 wherein said retainer ring includes a first annular portion
 for surrounding said outer circumferential portion of
 said object and for being brought into contact with said
 polishing pad, said first annular portion having a first 10
 outer rim portion, a first inner rim portion, an upper
 surface, and a second annular portion provided on said
 upper portion of said first annular portion, said second
 annular portion having a second outer rim portion, a
 second inner rim portion, a second inner rim portion, and 15
 a lower surface,
 wherein said second annular portion is fixed to said first
 annular portion by a mechanical joining,
 wherein an entirety of said upper surface of said first annu-
 lar portion is in contact with said lower surface of said 20
 second annular portion, and
 wherein said mechanical joining includes a first thread
 provided in a surface of said first outer rim portion of
 said first annular portion, and a projecting portion pro-
 truding from said second outer rim portion of said sec- 25
 ond annular portion and provided with a second thread
 configured to mate with said first thread.

8. A polishing machine, comprising:
 a polishing pad for polishing an object; and
 a gripping portion for gripping said object and bringing 30
 said object into contact with said polishing pad,
 wherein said gripping portion has a retainer ring for hold-
 ing an outer circumferential portion of said object,
 wherein said retainer ring includes a first annular portion 35
 for surrounding said outer circumferential portion of
 said object and for being brought into contact with said
 polishing pad, said first annular portion having a first
 outer rim portion, a first inner rim portion, an upper
 surface, and a second annular portion provided on said 40
 upper portion of said first annular portion, said second
 annular portion having a second outer rim portion, a
 second inner rim portion, a second inner rim portion, and
 a lower surface,
 wherein said retaining ring also includes a projecting por- 45
 tion protruding from one of said first outer rim portion
 and said first inner rim portion,

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wherein said retaining ring further includes a support por-
 tion, having a first portion configured to engage with
 said projecting portion to support said first annular por-
 tion, and having a second portion fixed to said second
 annular portion with a mechanical fastener,
 wherein said second annular portion is fixed to said first
 annular portion by a mechanical joining, and
 wherein an entirety of said upper surface of said first annu-
 lar portion is in contact with said lower surface of said
 second annular portion.

9. The polishing machine according to claim 7,
 wherein said second annular portion has a mechanical
 strength higher than that of said first annular portion.

10. The polishing machine according to claim 7, wherein
 said first annular portion is made of a resin.

11. The polishing machine according to claim 7, wherein
 said second annular portion is made of a metal.

12. The polishing machine according to claim 7, wherein
 said second annular portion is made of a ceramic material.

13. The polishing machine according to claim 7,
 wherein said polishing machine is a chemical mechanical
 polishing (CMP) apparatus, and
 wherein said polishing machine further includes a nozzle
 for supplying a slurry to said polishing pad.

14. The retainer ring according to claim 2, wherein the
 mechanical fastener is a screw.

15. The polishing machine according to claim 8, wherein
 the mechanical fastener is a screw.

16. The retainer ring according to claim 2, further compris-
 ing:
 another projecting portion protruding from the other of
 said at least one of said first outer rim portion and said
 first inner rim portion; and
 another support portion, having a first portion configured to
 engage with said another projecting portion, and having
 a second portion fixed to said second annular portion
 with another mechanical fastener.

17. The polishing machine according to claim 8,
 wherein the retaining ring further includes another project-
 ing portion protruding from the other of said at least one
 of said first outer rim portion and said first inner rim
 portion, and another support portion, having a first por-
 tion configured to engage with said another projecting
 portion, and having a second portion fixed to said second
 annular portion with another mechanical fastener.

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